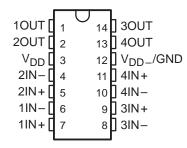
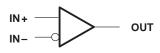
- Single- or Dual-Supply Operation
- Wide Range of Supply Voltages 1.4 V to 18 V
- Very Low Supply Current Drain 300 μA Typ at 5 V 130 μA Typ at 1.4 V
- Built-In ESD Protection
- High Input Impedance . . .  $10^{12} \Omega$  Typ
- Extremely Low Input Blas Current
   5 pA Typ
- Ultrastable Low Input Offset Voltage
- Input Offset Voltage Change at Worst-Case Input Conditions Typically 0.23 μV/Month, Including the First 30 Days
- Common-Mode Input Voltage Range Includes Ground
- Outputs Compatible With TTL, MOS, and CMOS
- Pin-Compatible With LM339

# D, N, OR PW PACKAGE (TOP VIEW)



### symbol (each comparator)



### description

This device is fabricated using LinCMOS<sup>TM</sup> technology and consists of four independent differential voltage comparators; each is designed to operate from a single power supply. Operation from dual supplies is also possible if the difference between the two supplies is 1.4 V to 18 V. Each device features extremely high input impedance (typically greater than  $10^{12} \Omega$ ), which allows direct interface to high-impedance sources. The outputs are n-channel open-drain configurations and can be connected to achieve positive-logic wired-AND relationships. The capability of the TLC354 to operate from a 1.4-V supply makes this device ideal for low-voltage battery applications.

The TLC354 has internal electrostatic discharge (ESD) protection circuits and has been classified with a 2000-V ESD rating tested under MIL-STD-833C, Method 3015. However, care should be exercised in handling this device as exposure to ESD may result in degradation of the device parametric performance.

The TLC354C is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C. The TLC354I is characterized for operation over the industrial temperature range of  $-40^{\circ}$  to  $85^{\circ}$ C. The TLC354M is characterized for operation over the full military temperature range  $-55^{\circ}$ C to  $125^{\circ}$ C.

#### **AVAILABLE OPTIONS**

	Via may	PAC	CHIP		
TA	V <sub>IO</sub> max AT 25°C			TSSOP (PW)	FORM (Y)
0°C to 70°C	5 mV	TLC354CD	TLC354CN	TLC354CPW	TLC354Y
-40°C to 85°C	5 mV	TLC354ID	TLC354IN	_	_
-55°C to 125°C	5 mV	TLC354MD	TLC354MN	_	_

The D packages are available taped and reeled. Add R suffix to device type (e.g., TLC354CDR).



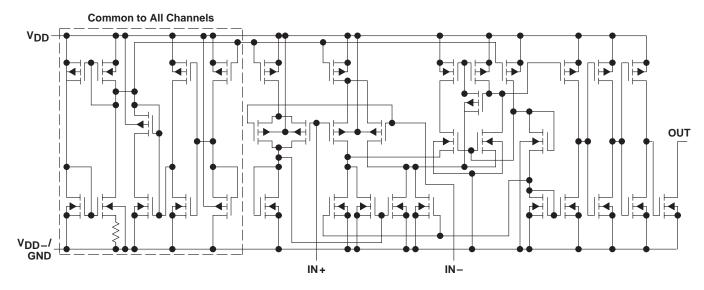
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TEXAS INSTRUMENTS

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### equivalent schematic (each comparator)



## absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V <sub>DD</sub> (see Note 1)	18 V
Differential input voltage, V <sub>ID</sub> (see Note 2)	
Input voltage, V <sub>I</sub>	V <sub>DD</sub>
Input voltage range, V <sub>I</sub>	
Output voltage, V <sub>O</sub>	18 V
Input current, I <sub>1</sub>	±5 mA
Output current, IO	20 mA
Duration of output short circuit to ground (see Note 3)	Unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T <sub>A</sub> : TLC354C	0°C to 70°C
TLC354I	–40°C to 85°C
TLC354M	–55°C to 125°C
Storage temperature range	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values except differential voltages are with respect to network ground.
  - 2. Differential voltages are at IN+ with respect to IN-.
  - 3. Short circuits from outputs to VDD can cause excessive heating and eventual device destruction.

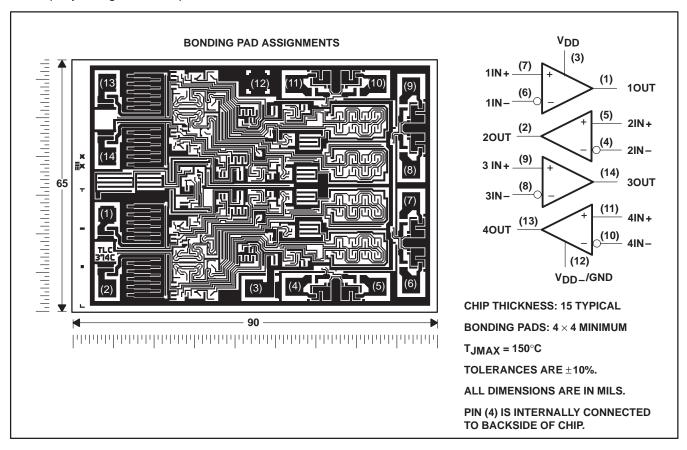
#### **DISSIPATION RATING TABLE**

PACKAGE	$T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR	DERATE ABOVE T <sub>A</sub>	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 85°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
D	500 mW	7.6 mW/°C	84°C	500 mW	494 mW	190 mW
N	500 mW	9.2 mW/°C	96°C	500 mW	500 mW	230 mW
PW	700 mW	5.6 mW/°C	25°C	448 mW	N/A	N/A



### **TLC364Y chip information**

This chip, when properly assembled, displays characteristics similar to the TLC354C. Thermal compression or ultrasonic bonding can be used on the doped-aluminum bonding pads. Chips can be mounted with conductive epoxy or a gold-silicon preform.



## recommended operating conditions

		TLC3	54C	TLC	354I	TLC3	54M	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V <sub>DD</sub>		1.4	16	1.4	16	1.4	16	V
	V <sub>DD</sub> = 1.4 V	0	0.2	0	0.2	0	0.2	
Common-mode input voltage, V <sub>IC</sub>	$V_{DD} = 5 V$	0	3.5	0	3.5	0	3.5	V
	V <sub>DD</sub> = 10 V	0	8.5	0	8.5	0	8.5	
Operating free-air temperature, TA		0	70	-40	85	-55	125	°C

# electrical characteristics at specified free-air temperature, $V_{DD} = 1.4 \text{ V}$

PARAMETER		TEST CO	NDITIONS	T. †	TI	LC354C		1	LC354I		TLC354M			UNIT
	PARAMETER	1251 CO	NDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V/10	Input offeet voltage	Via – Vianmin	Soo Noto 4	25°C		2	5		2	5		2	5	mV
VIO	Input offset voltage	$V_{IC} = V_{ICRmin}$	See Note 4	Full range			6.5			7			10	IIIV
l. a	Input offset current			25°C		1			1			1		рА
10	input onset current			MAX			0.3			1			10	nA
1.5	Input bigg gurrent			25°C		5			5			5		pА
IB	Input bias current			MAX			0.6			2			20	nA
VICR	Common-mode input voltage			I 25°C: I	0 to			0 to			0 to			V
VICR	range		_	25 0	0.2			0.2			0.2			V
	High-level output current	V <sub>ID</sub> = 1 V	V <sub>OH</sub> = 5 V	25°C		0.1			0.1			0.1		nA
ЮН	riigii-ievei output current	VID = 1 V	V <sub>OH</sub> = 15 V	Full range			1			1			1	μΑ
V	Low lovel output voltage	V:- 0.5.V	Ja. 06 m/	25°C		100	200		100	200		100	200	mV
VOL	Low-level output voltage	$V_{ID} = -0.5 V$ ,	IOL = 0.6  mA	Full range			200			200			200	IIIV
loL	Low-level output current	$V_{ID} = -0.5 V$ ,	V <sub>OL</sub> = 300 mV	25°C	1	1.6		1	1.6		1	1.6		mA
1	Supply current	V:- 0.5.V	Nolood	25°C		130	300		130	300		130	300	
IDD	(four comparators)	$V_{ID} = 0.5 V,$	No load	Full range			400			400			400	μΑ

<sup>†</sup> All characteristics are measured with zero common-mode input voltage unless otherwise noted. Full range is 0°C to 70°C for TLC354C, -40°C to 85°C for TLC354I, and -55°C to 125°C for the TLC354M. MAX is 70°C for TLC354C, 85°C TLC354I, and 125°C for the TLC354M. IMPORTANT: See Parameter Measurement Information.



NOTE 4: The offset voltage limits given are the maximum values required to drive the output above 1.25 V or below 150 mV with a 10-kΩ resistor between the output and V<sub>DD</sub>. They can be verified by applying the limit value to the input and checking for the appropriate output state.

## electrical characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	PARAMETER	TEST CON	IDITIONS	T. †	TLC	354C		TLC	C354I		TLC354M			UNIT
	PARAMETER	1EST CON	IDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V	Input offset voltage	V V min	See Note 5	25°C		2	5		2	5		2	5	mV
VIO	input onset voltage	$V_{IC} = V_{ICR}min,$	See Note 5	Full range			6.5			7			10	IIIV
lio.	Input offset current		2			1			1			1		pА
110	input onset current			MAX			0.3			1			10	nA
lin.	Input bias current			25°C		5			5			5		pА
ΙΒ	input bias current			MAX			0.6			2			20	nA
V. 0.5	Common-mode input			25°C	0 to V <sub>DD</sub> -1			0 to V <sub>DD</sub> -1			0 to V <sub>DD</sub> -1			V
VICR	voltage range			Full range	0 to V <sub>DD</sub> -1.5			0 to V <sub>DD</sub> -1.5			0 to V <sub>DD</sub> -1.5			V
lau	High-level output current	V:= - 1 V	V <sub>OH</sub> = 5 V	25°C		0.1			0.1			0.1		nA
ІОН	nign-level output current	V <sub>ID</sub> = 1 V	V <sub>OH</sub> = 15 V	Full range			1			1			1	μΑ
V/0:	Low-level output voltage	V:= - 1 V	la: - 4 m^	25°C		150	400		150	400		150	400	mV
VOL	Low-level output voltage	$V_{ID} = -1 V$	$I_{OL} = 4 \text{ mA}$	Full range			700			700			700	IIIV
l <sub>OL</sub>	Low-level output current	$V_{ID} = -1 V$ ,	$V_{OL} = 1.5 \text{ mV}$	25°C	6	16		6	16		6	16		mA
Inn	Supply current	\/\r\= 1 \/	No load	25°C		0.3	0.6		0.3	0.6		0.3	0.6	m A
IDD	(four comparators)	$V_{ID} = 1 V$	INU IUAU	Full range			0.8			0.8			0.8	mA

<sup>†</sup> All characteristics are measured with zero common-mode input voltage unless otherwise noted. Full range is 0°C to 70 °C for TLC354C, -40°C to 85°C for TLC354I, and -55°C to 125°C for the TLC354M. MAX is 70°C for TLC354C, 85°C TLC354I, and 125°C for the TLC354M. IMPORTANT: See Parameter Measurement Information.

### switching characteristics, V<sub>DD</sub> = 5 V, T<sub>A</sub> = 25°C

PARAMETER	TEST CO	TLC35 TI	UNIT			
			MIN	TYP	MAX	
Response time	R <sub>L</sub> connected to 5 V through 5.1 k $\Omega$ ,	100-mV input step with 5-mV overdrive		650		no
Response time	$C_L = 15 \text{ pF}^{\ddagger}$ , See Note 6	TTL-level input step		200		ns

<sup>‡</sup>C<sub>L</sub> includes probe and jig capacitance.

NOTE 6: The response time specified is the interval between the input step function and the instant when the output crosses 1.4 V.

NOTE 5: The offset voltage limits given are the maximum values required to drive the output above 4 V or below 400 mV with a 10-kΩ resistor between the output and V<sub>DD</sub>. They can be verified by applying the limit value to the input and checking for the appropriate output state.

# electrical characteristics at specified free-air temperature, $V_{DD}$ = 1.4 V, $T_A$ = 25°C (unless otherwise noted)

	PARAMETER		TEST CONDITIONS				UNIT
	FARAMETER	TEST CON	IDITIONS	MIN	TYP	MAX	UNIT
VIO	Input offset voltage	$V_{IC} = V_{ICR} min,$	See Note 4		2	5	mV
IIO	Input offset current				1		рА
I <sub>IB</sub>	Input bias current				5		рА
VICR	Common-mode input voltage range			0 to 0.2			V
ІОН	High-level output current	V <sub>ID</sub> = 1 V,	V <sub>OH</sub> = 5 V		0.1		nA
VOL	Low-level output voltage	$V_{ID} = -0.5 V$ ,	$I_{OL} = 0.6 \text{ mA}$		100	200	mV
loL	Low-level output current	$V_{ID} = -0.5 V$ ,	$V_{OL} = 300 \text{ mV}$	1	1.6		mA
I <sub>DD</sub>	Supply current (four comparators)	$V_{ID} = 0.5 V$ ,	No load		130	300	μΑ

NOTE 4: The offset voltage limits given are the maximum values required to drive the output above 1.25 V or below 150 mV with a 10-k $\Omega$  resistor between the output and V<sub>DD</sub>. They can be verified by applying the limit value to the input and checking for the appropriate output state.

# electrical characteristics at specified free-air temperature, $V_{DD}$ = 5 V, $T_A$ = 25°C (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	TL	.C354Y		UNIT
	PARAMETER	TEST CON	MIN	TYP	MAX	UNII	
VIO	Input offset voltage	V <sub>IC</sub> = V <sub>ICR</sub> min,	See Note 5		2	5	mV
IIO	Input offset current				1		pА
I <sub>IB</sub>	Input bias current				5		pА
VICR	Common-mode input voltage range			0 to V <sub>DD</sub> -1			V
ЮН	High-level output current	V <sub>ID</sub> = 1 V,	V <sub>OH</sub> = 5 V		0.1		nA
VOL	Low-level output voltage	$V_{ID} = -1 V$ ,	I <sub>OL</sub> = 4 mA		150	400	mV
IOL	Low-level output current	$V_{ID} = -1 V$ ,	V <sub>OL</sub> = 1.5 mV	6	16		mA
$I_{DD}$	Supply current (four comparators)	V <sub>ID</sub> = 1 V,	No load		0.3	0.6	mA

NOTE 5: The offset voltage limits given are the maximum values required to drive the output above 4 V or below 400 mV with a 10-kΩ resistor between the output and V<sub>DD</sub>. They can be verified by applying the limit value to the input and checking for the appropriate output state.

# switching characteristics, $V_{DD}$ = 5 V, $T_A$ = 25°C

PARAMETER	TEST CO	Т	UNIT				
PARAMETER	TEST CC	MIN	TYP	MAX	UNIT		
Response time	R <sub>L</sub> connected to 5 V through 5.1 k $\Omega$ ,	100-mV input step with 5-mV overdrive		650		20	
Response time	$C_L = 15 \text{ pF}^{\ddagger}$ , See Note 6	TTL-level input step	200			ns	

<sup>‡</sup>C<sub>L</sub> includes probe and jig capacitance.

NOTE 6: The response time specified is the interval between the input step function and the instant when the output crosses 1.4 V.



#### PARAMETER MEASUREMENT INFORMATION

The digital output stage of the TLC354 can be damaged if it is held in the linear region of the transfer curve. Conventional operational amplifier/comparator testing incorporates the use of a servo loop that is designed to force the device output to a level within this linear region. Since the servo-loop method of testing cannot be used, the following alternative for measuring parameters such as input offset voltage, common-mode rejection, etc., are offered.

To verify that the input offset voltage falls within the limits specified, the limit value is applied to the input as shown in Figure 1(a). With the noninverting input positive with respect to the inverting input, the output should be high. With the input polarity reversed, the output should be low.

A similar test can be made to verify the input offset voltage at the common-mode extremes. The supply voltages can be slewed as shown in Figure 1(b) for the V<sub>ICR</sub> test, rather than changing the input voltages, to provide greater accuracy.

A close approximation of the input offset voltage can be obtained by using a binary search method to vary the differential input voltage while monitoring the output state. When the applied input voltage differential is equal but opposite in polarity to the input offset voltage, the output changes state.

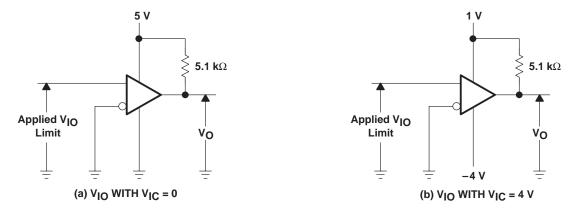


Figure 1. Method for Verifying That Input Offset Voltage is Within Specified Limits

#### PARAMETER MEASUREMENT INFORMATION

Figure 2 illustrates a practicle circuit for direct dc measurement of input offset voltage that does not bias the comparator into the linear region. The circuit consists of a switching-mode servo loop in which U1a generates a triangular waveform of approximately 20-mV amplitude. U1b acts as a buffer with C2 and R4 removing any residual dc offset. The signal is then applied to the inverting input of the comparator under test, while the noninverting input is driven by the output of the integrator formed by U1c through the voltage divider formed by R9 and R10. The loop reaches a stable operating point when the output of the comparator under test has a duty cycle of exactly 50%, which can only occur when the incoming triangle wave is sliced symmetrically or when the voltage at the noninverting input exactly equals the input offset voltage.

Voltage divider R9 and R10 provides a step up of the input offset voltage by a factor of 100 to make measurement easier. The values of R5, R8, R9, and R10 can significantly influence the accuracy of the reading; therefore, it is suggested that their tolerance level be 1% or lower.

Measuring the extremely low values of input current requires isolation from all other sources of leakage current and compensation for the leakage of the test socket and board. With a good picoammeter, the socket and board leakage can be measured with no device in the socket. Subsequently, this open-socket leakage value can be subtracted from the measurement obtained with a device in the socket to obtain the actual input current of the device.

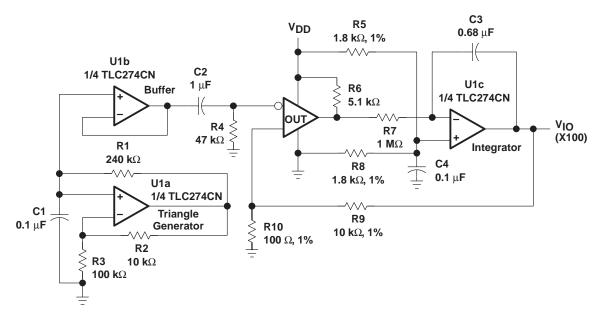
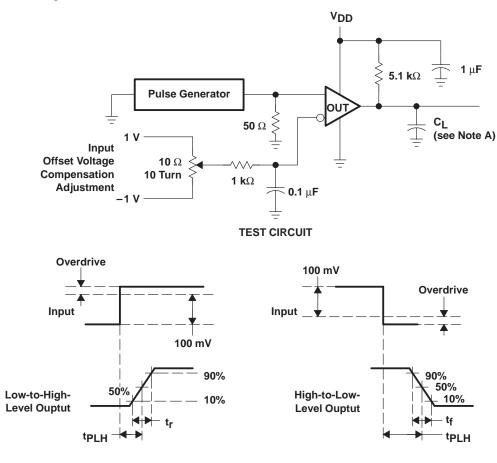


Figure 2. Test Circuit for Input Offset Voltage Measurement



#### PARAMETER MEASUREMENT INFORMATION

Response time is defined as the interval between the application of an input step function and the instant when the output reaches 50% of its maximum value. Response time, low-to-high-level output, is measured from the trailing edge of the input pulse. Response-time measurement at low input signal levels can be greatly affected by the input offset voltage. The offset voltage should be balanced by the adjustment at the inverting input (as shown in Figure 3) so that the circuit is just at the transition point. Then a low signal, for example, 105-mV or 5-mV overdrive, causes the output to change.



**VOLTAGE WAVEFORMS** 

NOTE A:  $C_L$  includes probe and jig capacitance.

Figure 3. Response, Rise, and Fall Times Test Circuit and Voltage Waveforms

#### PACKAGE OPTION ADDENDUM

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### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp (3)
TLC354CD	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354CDG4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354CN	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TLC354CNE4	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TLC354CPW	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354CPWG4	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354CPWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354CPWRG4	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354ID	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354IDG4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC354IN	OBSOLETE	PDIP	N	14		TBD	Call TI	Call TI

 $^{(1)}$  The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <a href="http://www.ti.com/productcontent">http://www.ti.com/productcontent</a> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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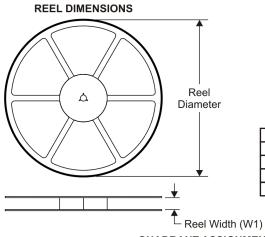
# **PACKAGE OPTION ADDENDUM**

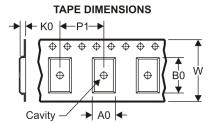
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PACKAGE MATERIALS INFORMATION

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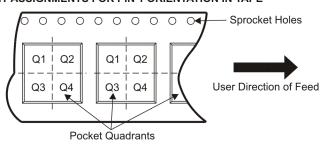
### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC354CPWR	TSSOP	PW	14	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1

**PACKAGE MATERIALS INFORMATION** 

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#### \*All dimensions are nominal

Device Package Type		Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TLC354CPWR	TSSOP	PW	14	2000	346.0	346.0	29.0	

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